

Ceramic substrates for high voltage power electronics: Past, present and future

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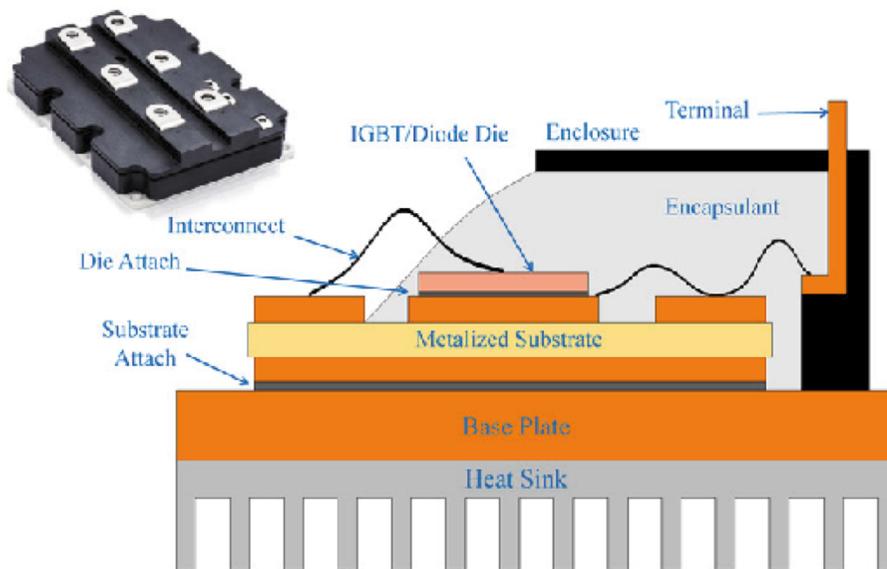


1. Power electronics: SC Devices & Insulation



Electrical Insulating environment of the power semiconductor die

Classical structure

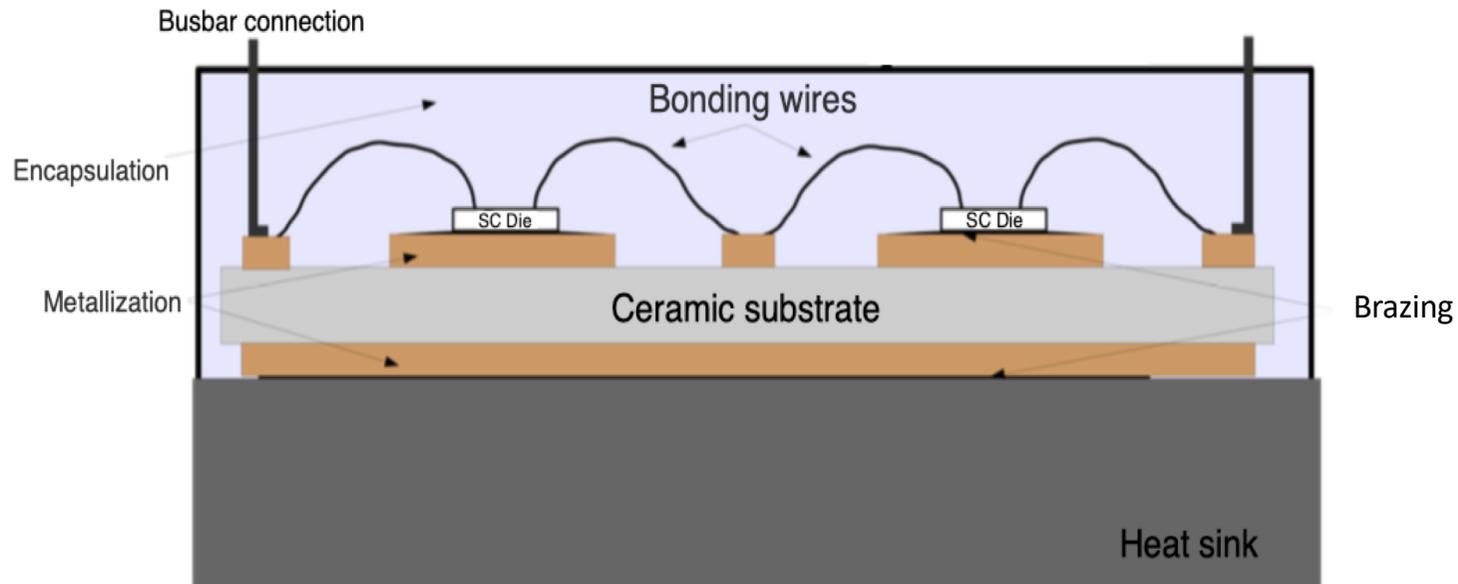


=> 4 types of insulating functions :

- Insulating substrate
- Inter-metal insulation
- Semiconductor surface passivation
- Insulating filler / encapsulation

Le, VN et al. Procedia Structural Integrity, 2016, 2614-2622

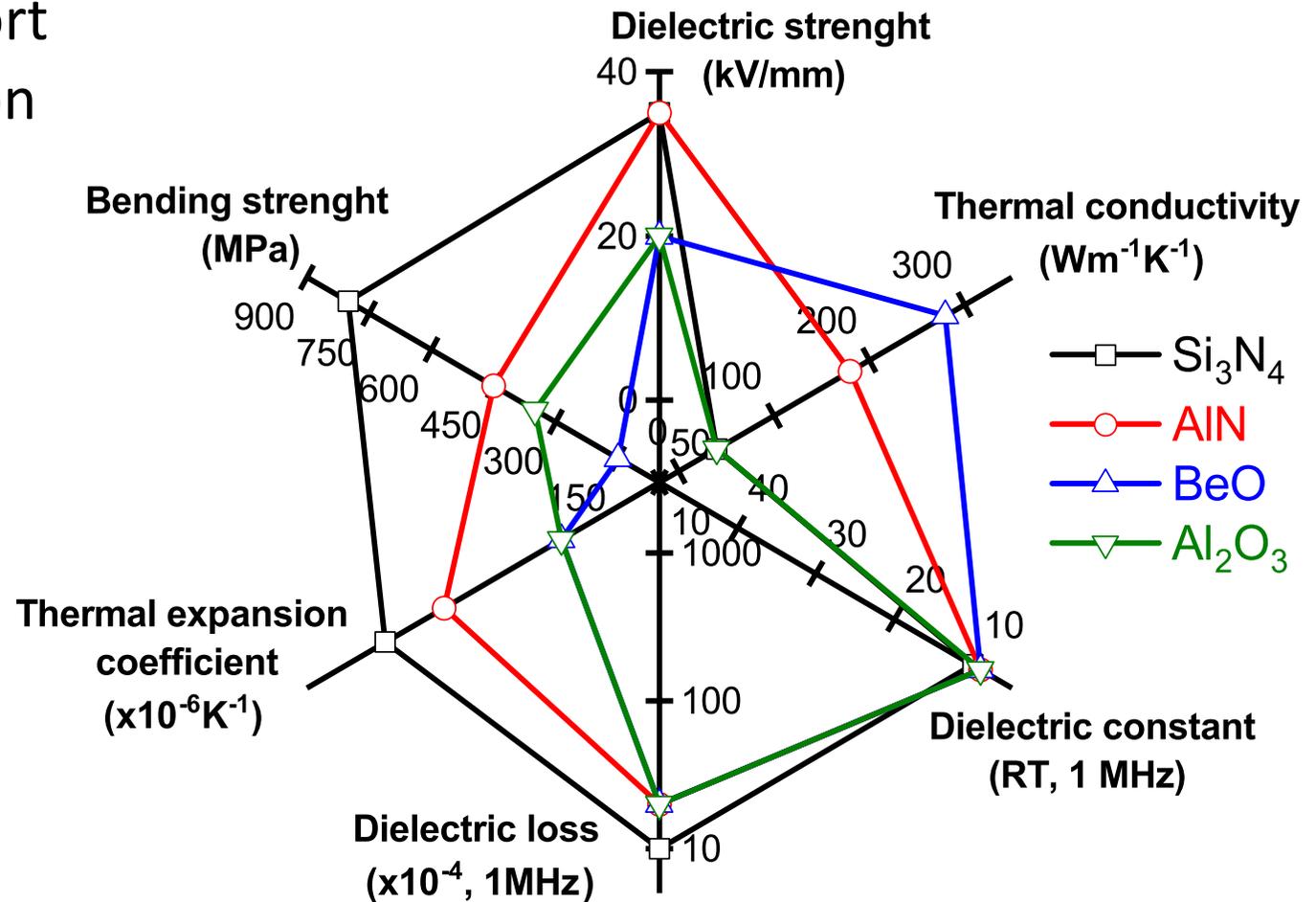
1. Power electronics: Ceramic substrate



- Thermal path
- Mechanical support
- Electrical insulation

2. Physical properties of ceramics

- Thermal path
- Mechanical support
- Electrical insulation



2. Physical properties of ceramics

- Thermal path
- Mechanical support
- Electrical insulation

Ceramic substrate	Thermal conductivity (W/m-K) (typical values)
Al_2O_3	30-40
Si_3N_4	35-60
AlN	140-200

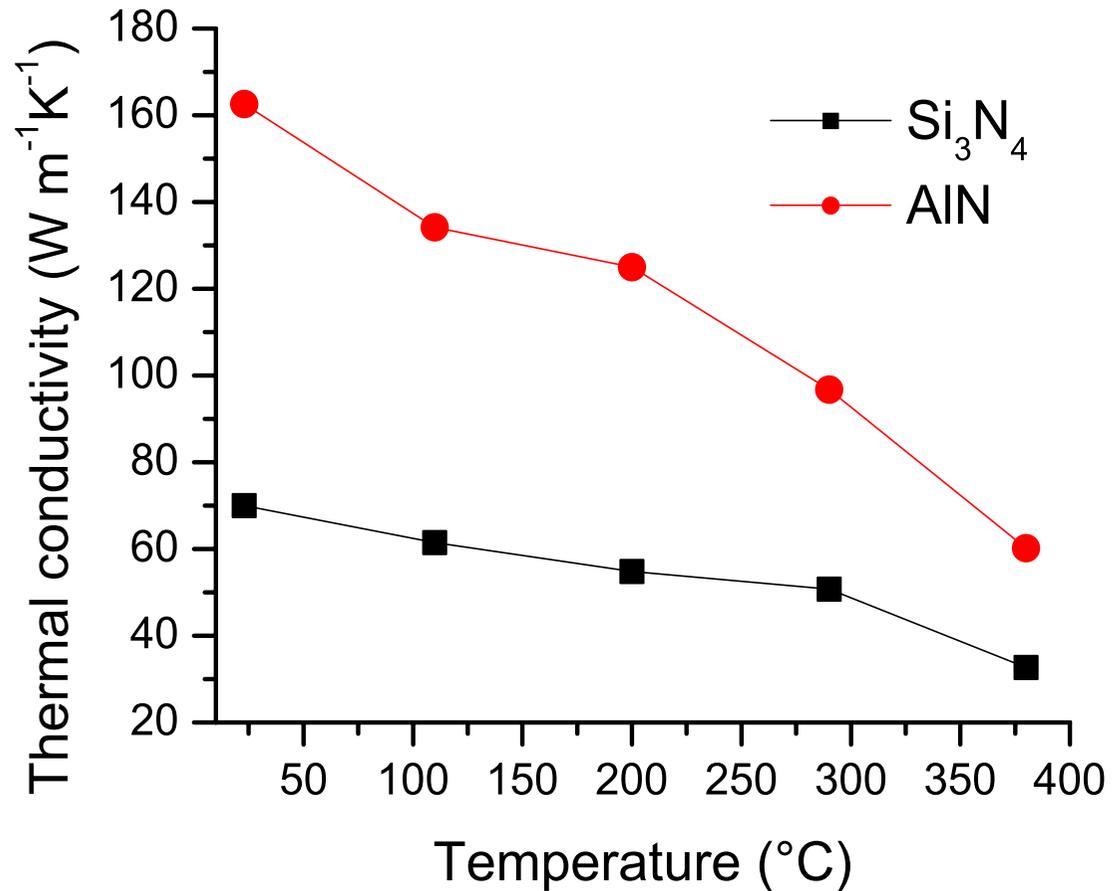
Aluminum nitride:

High thermal conductivity

3. Dielectric properties of ceramic materials



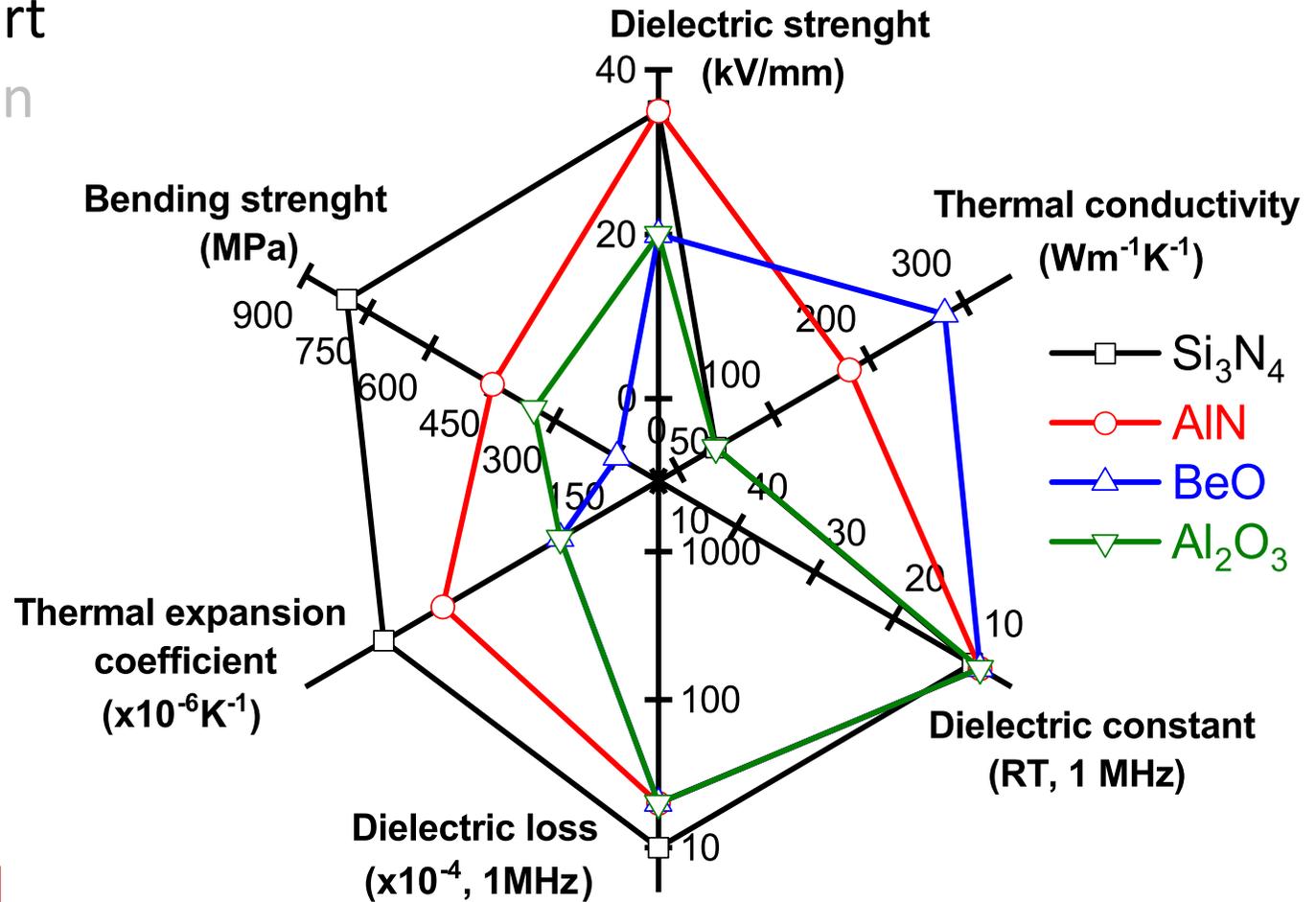
Thermal conductivity of AlN is high, but it decreases as temperature increases



3. Physical properties of ceramics

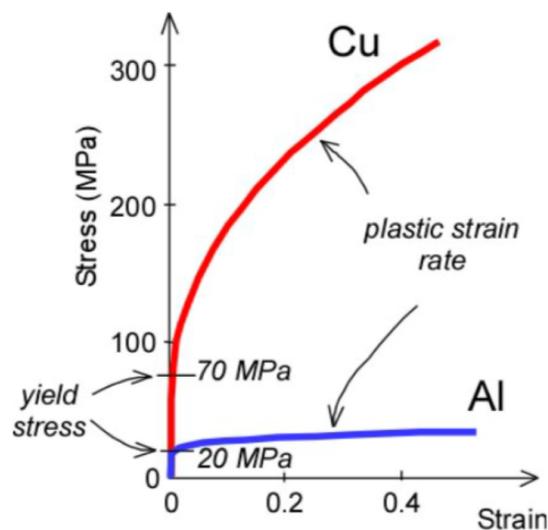
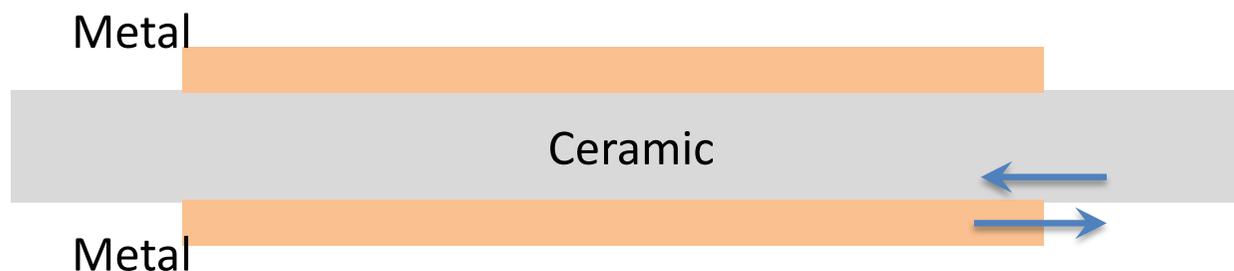


- Thermal path
- Mechanical support
- Electrical insulation

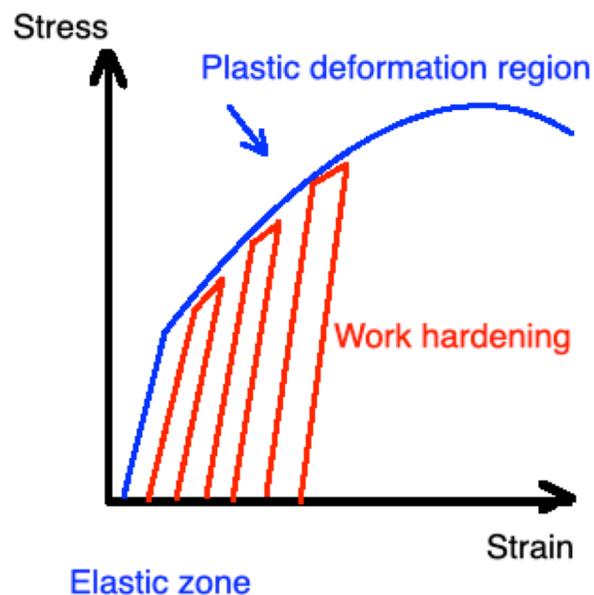


Metal-ceramic bonding

4. Mechanical failure of metallized ceramics

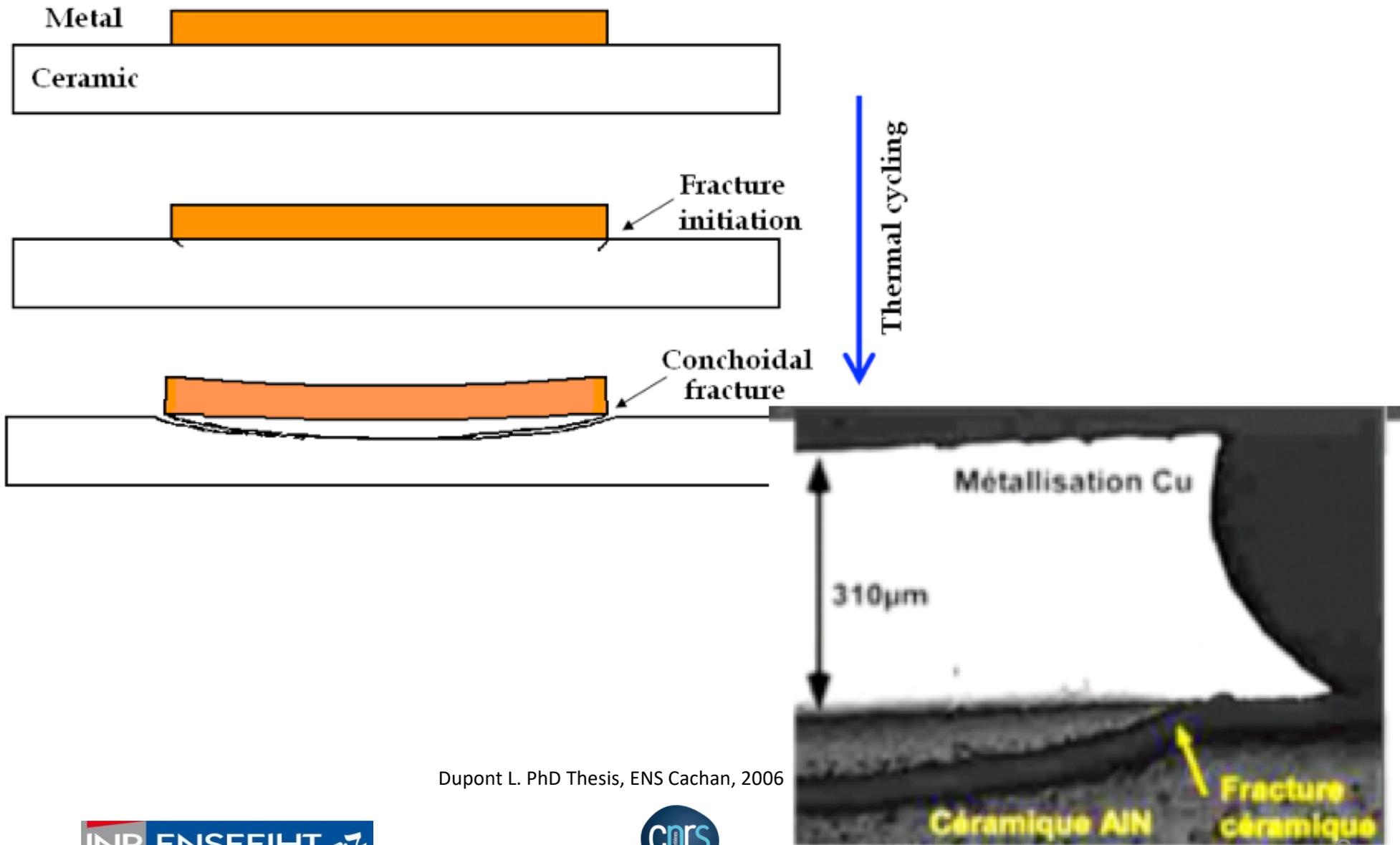


Dupont et al. Microelectronics Reliability, 2006, 1766-1771.



- Dimensions (i.e. thickness)
- Edges of metallization
- Interface
- Temperature span

4. Mechanical failure of metallized ceramics

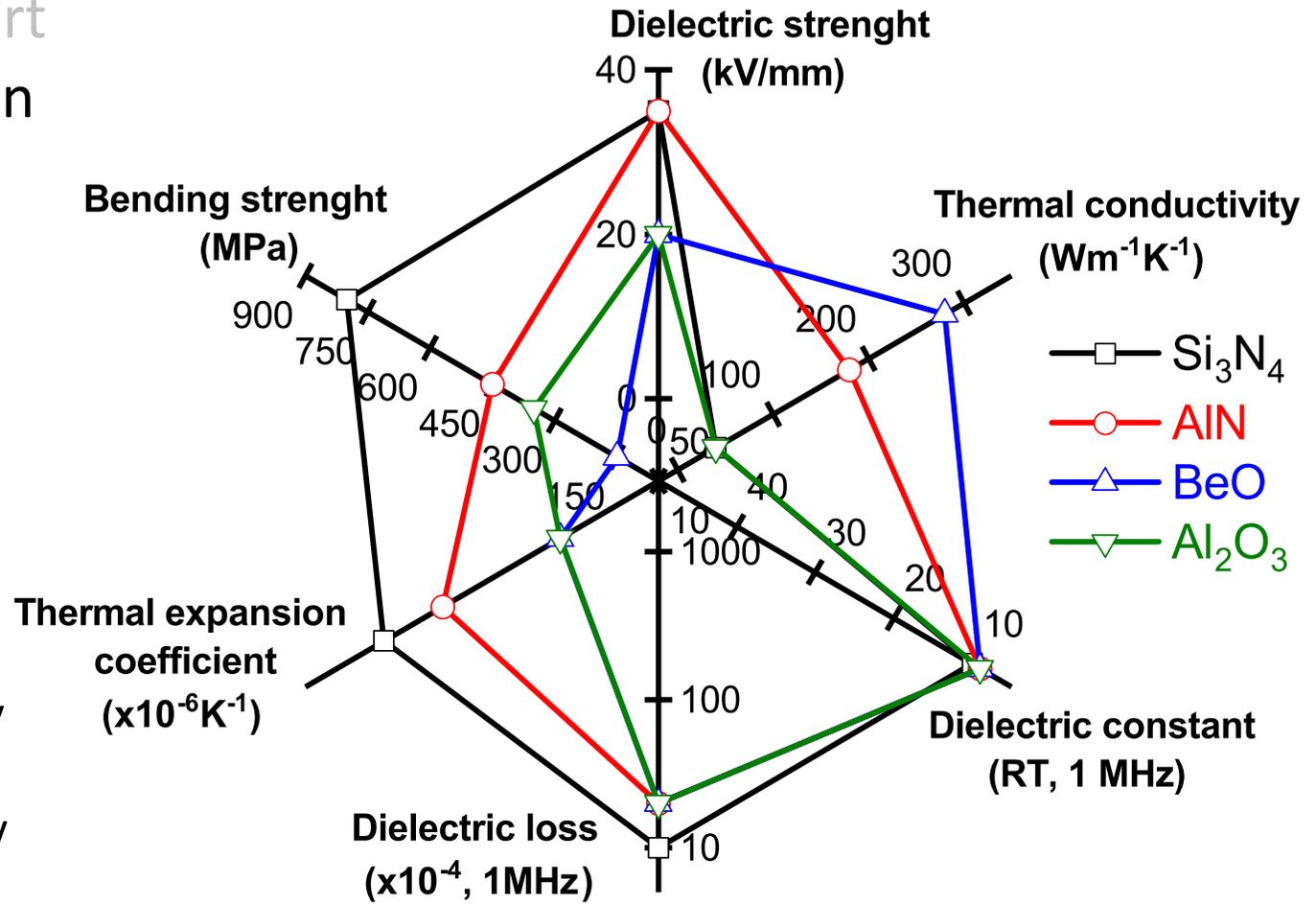


Dupont L. PhD Thesis, ENS Cachan, 2006

5. Physical properties of ceramics



- Thermal path
- Mechanical support
- Electrical insulation



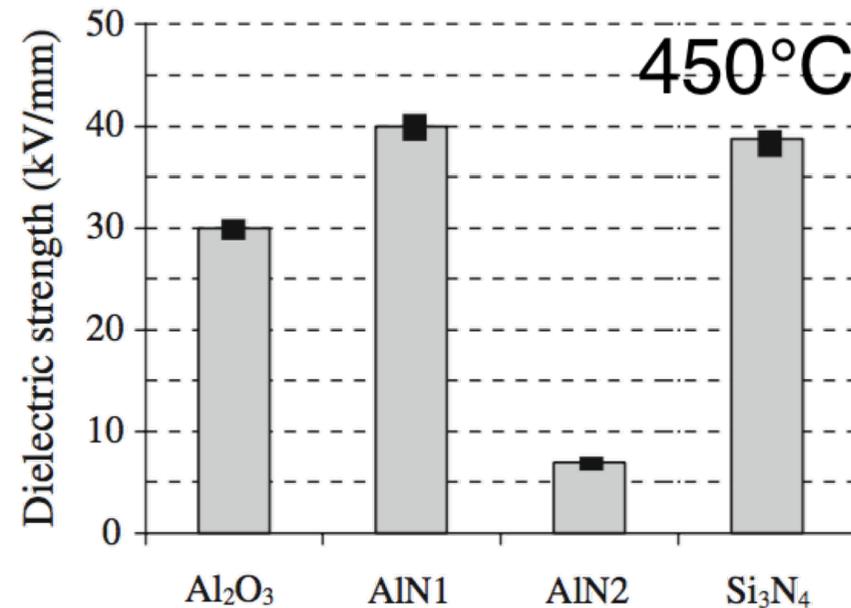
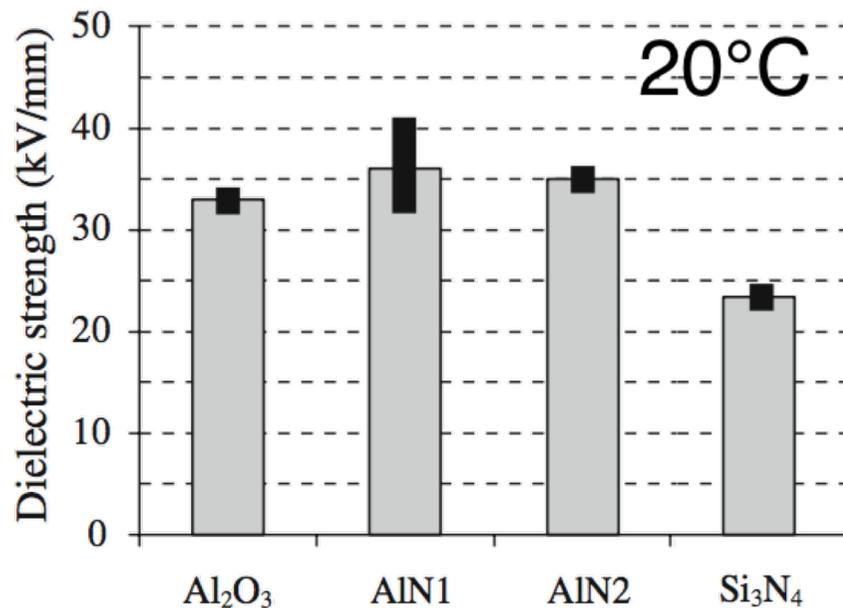
- Dielectric permittivity
- Dielectric losses
- Electrical conductivity
- Dielectric strength

5. Dielectric properties of ceramic materials



Dielectric breakdown in ceramics is dependent on:

- Material composition
- Thickness
- Temperature



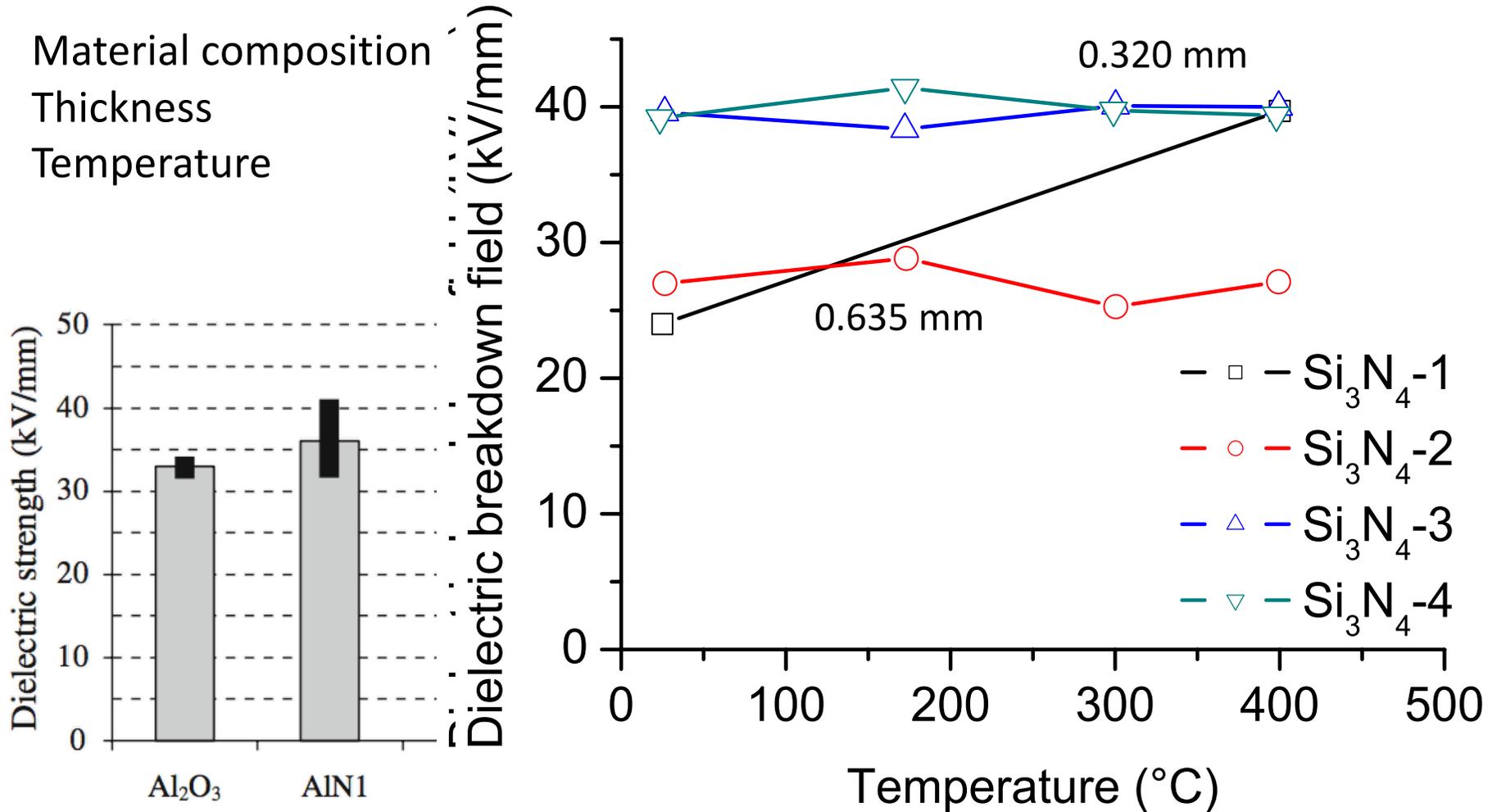
Chasserio et al. Journal of Electronic Materials 38.1 (2009): 164-174.

5. Dielectric properties of ceramic materials



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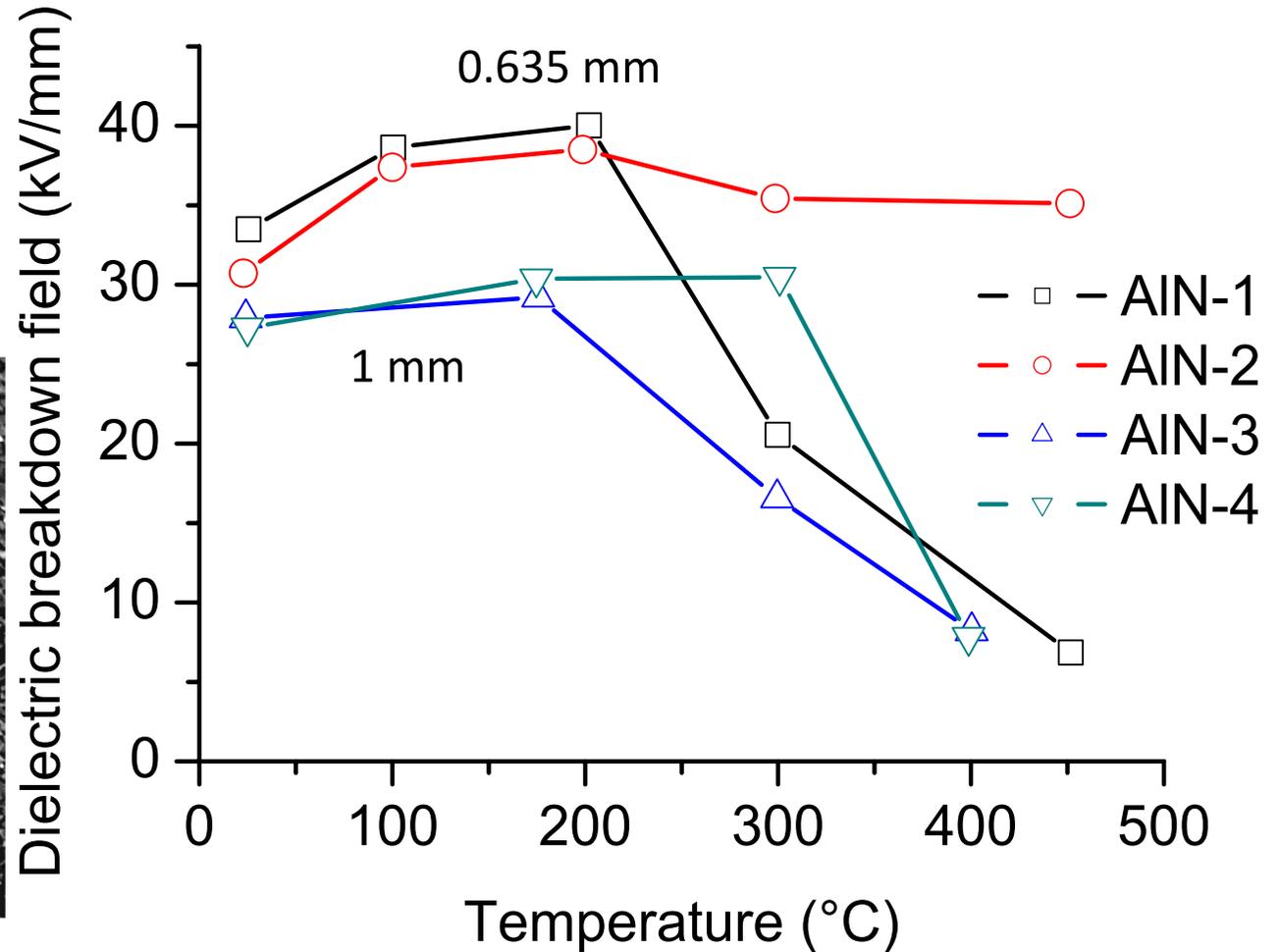
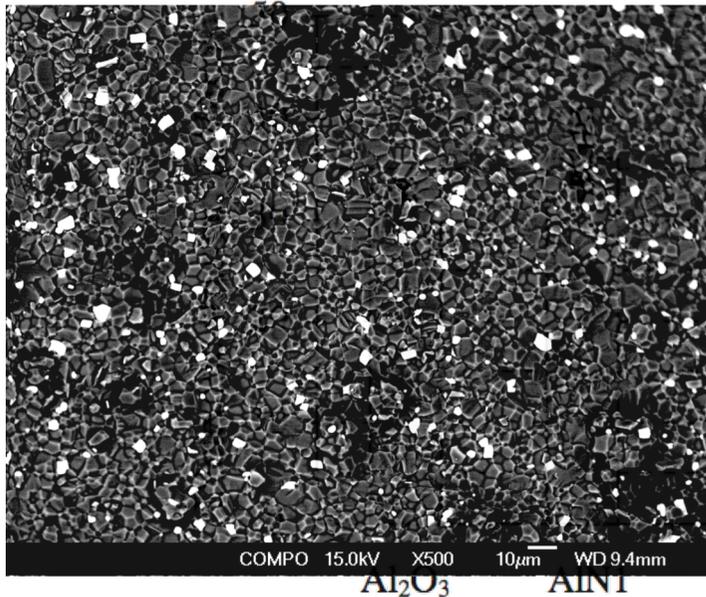


5. Dielectric properties of ceramic materials

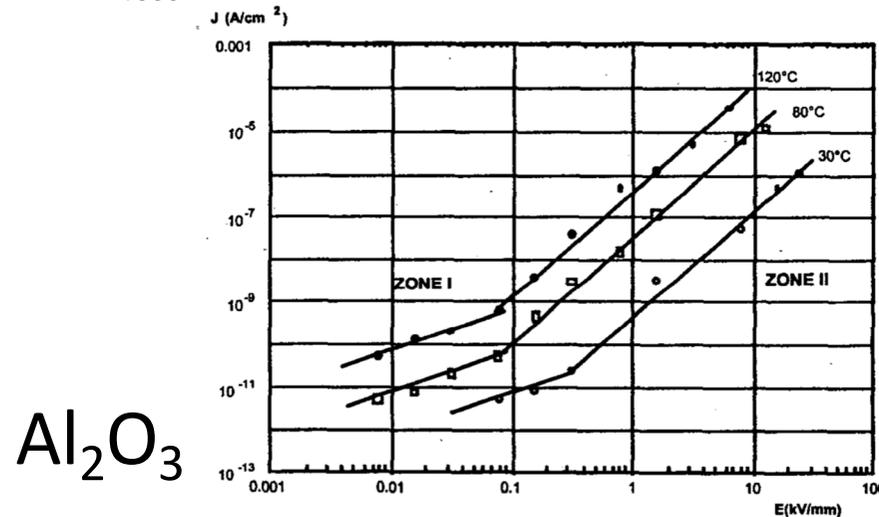
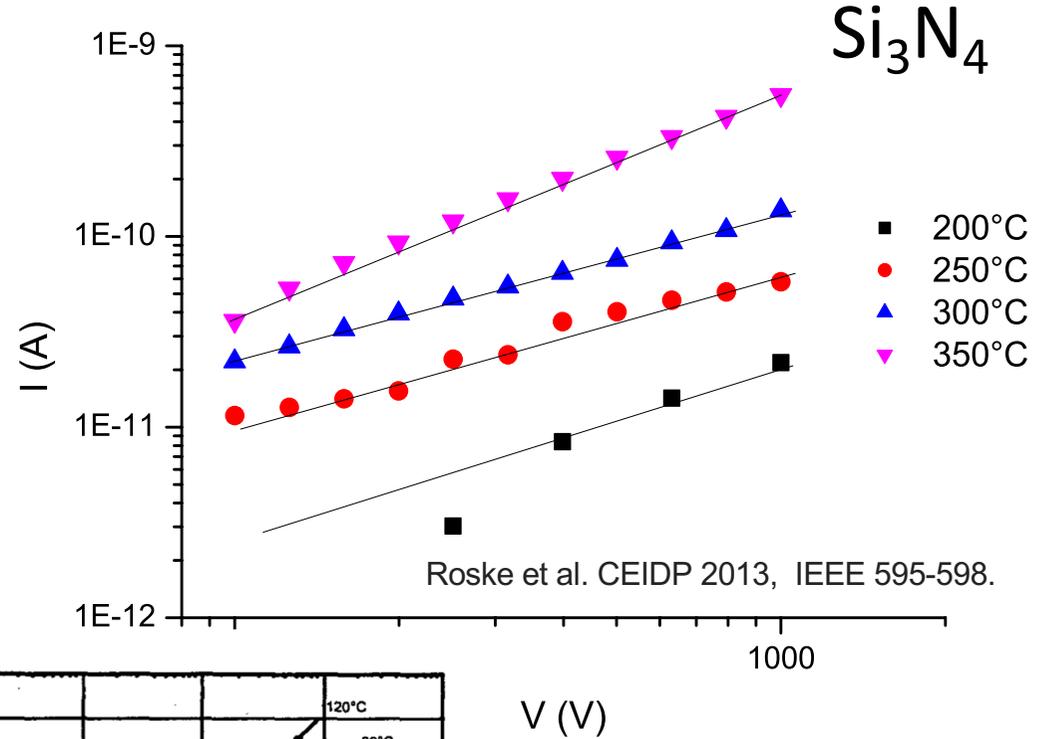
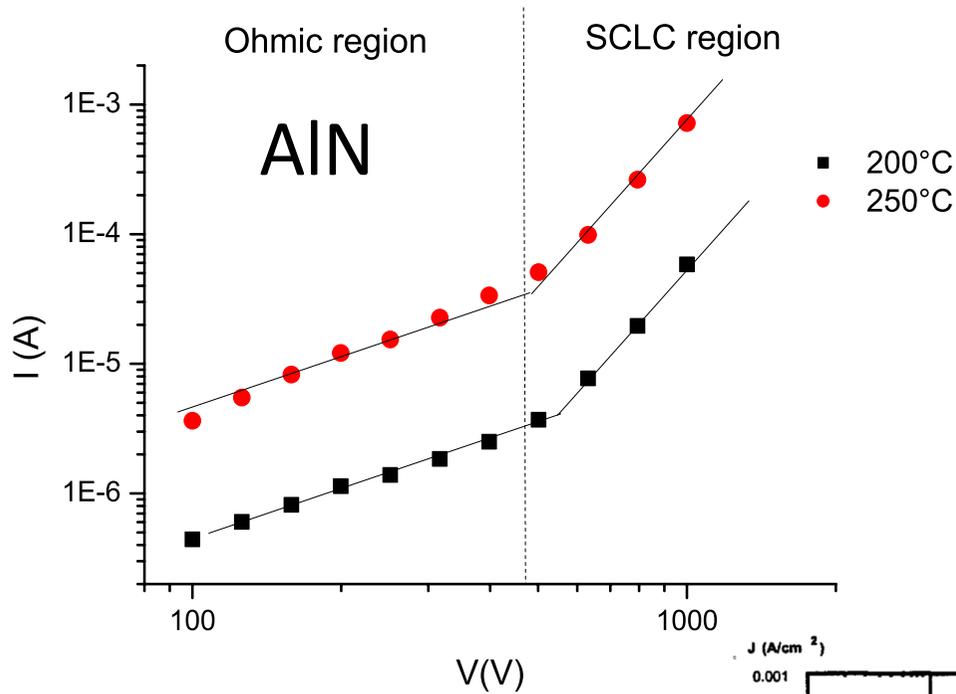


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5. Dielectric properties of ceramic materials

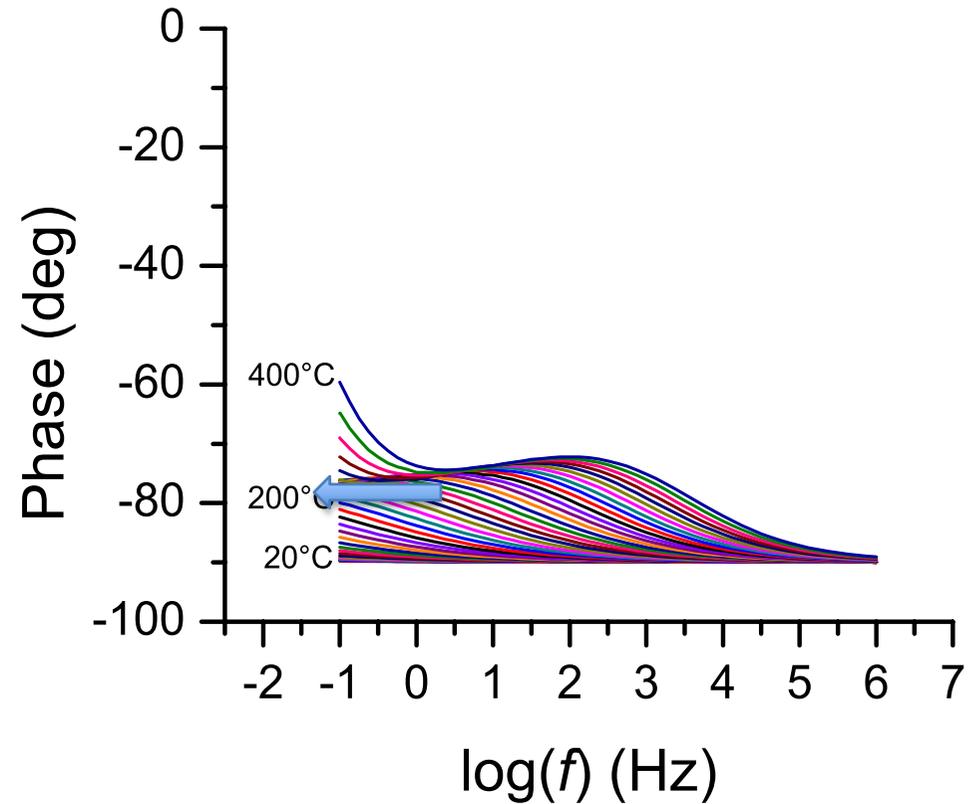
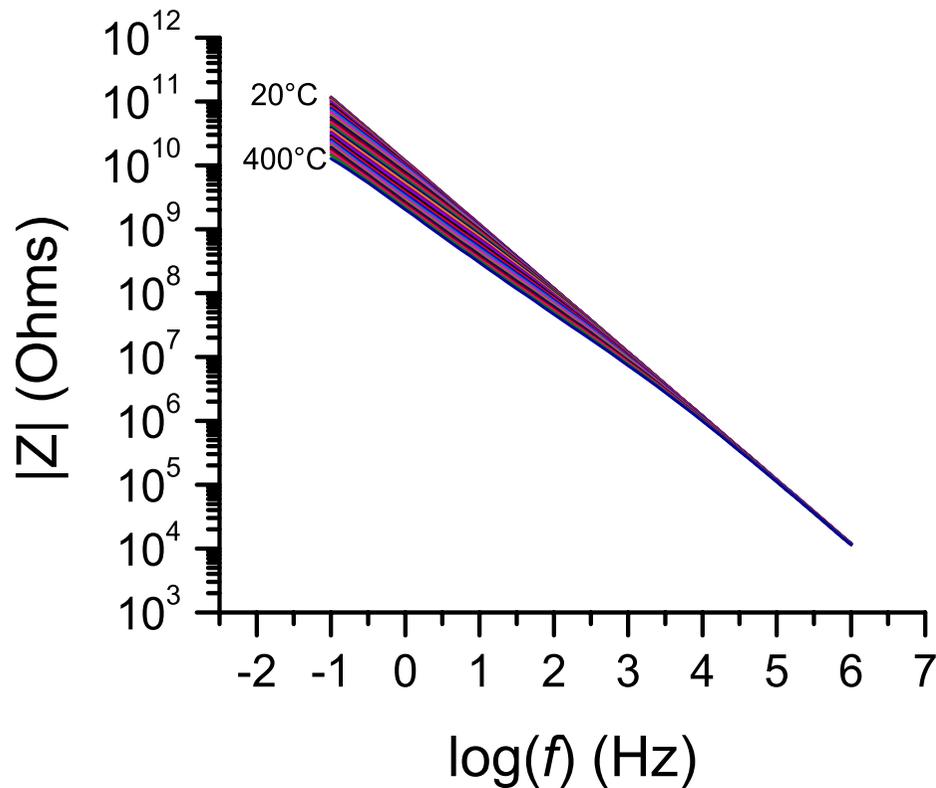


5. Dielectric properties of ceramic materials



Broadband dielectric spectroscopy

Si_3N_4

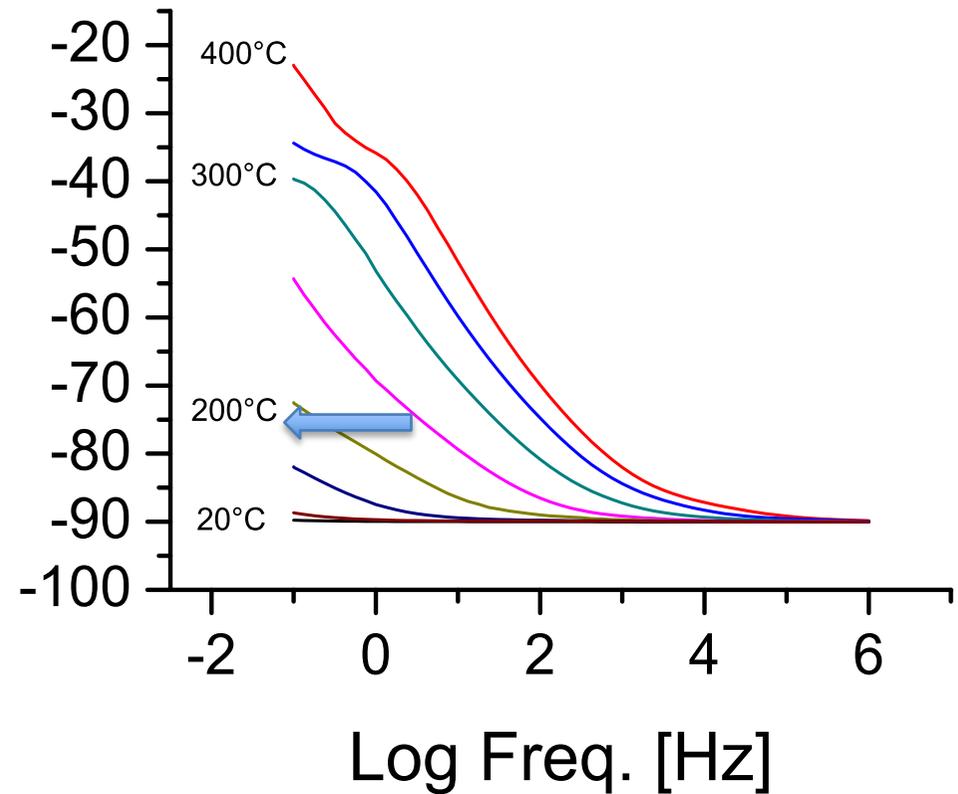
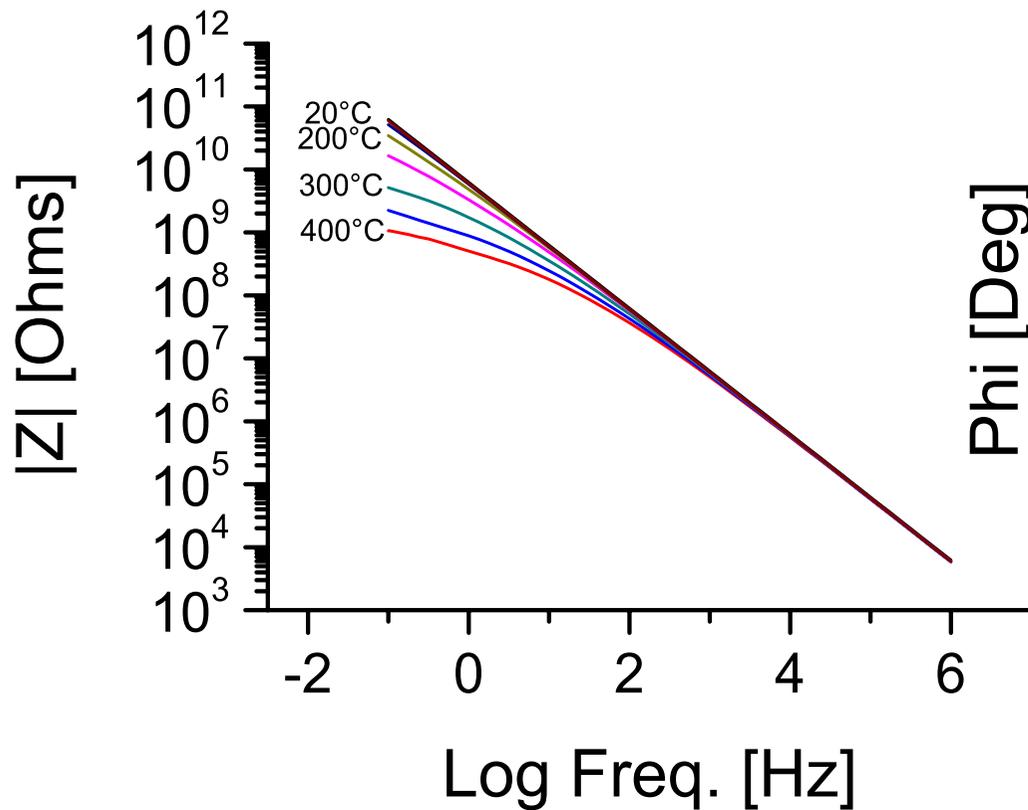


5. Dielectric properties of ceramic materials



Broadband dielectric spectroscopy

AlN



5. Dielectric properties of ceramic materials



- All dielectric properties are impacted by temperature
 - Permittivity
 - Losses
 - Conductivity
- Both AlN and Si₃N₄ keep a dielectric behavior below 200°C

5. Conclusions on the state of the art



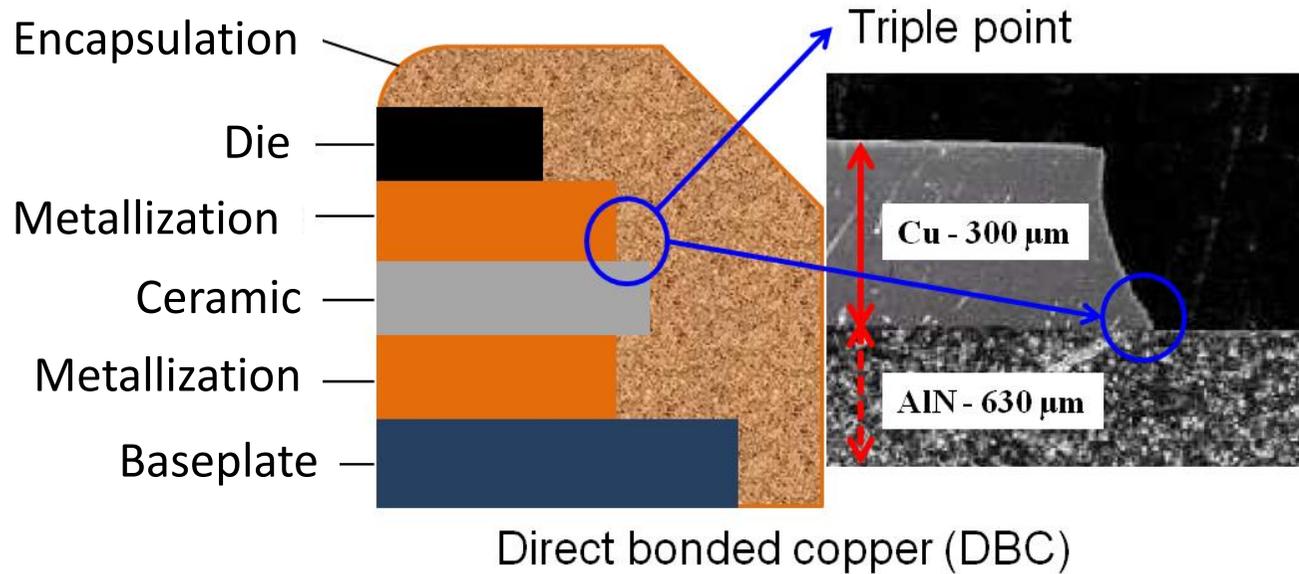
- Thermal properties
- Mechanical properties
- Dielectric properties

In current applications, with the right choices, compromises can be achieved in terms of performance and reliability

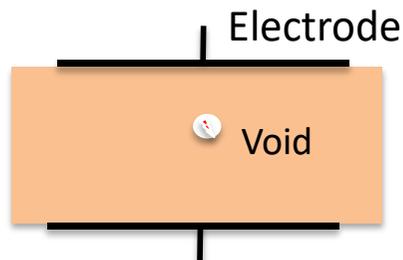
But the ceramic substrate is not alone in a power module ...

6. Impact of high dV/dt on insulation

High field at triple point



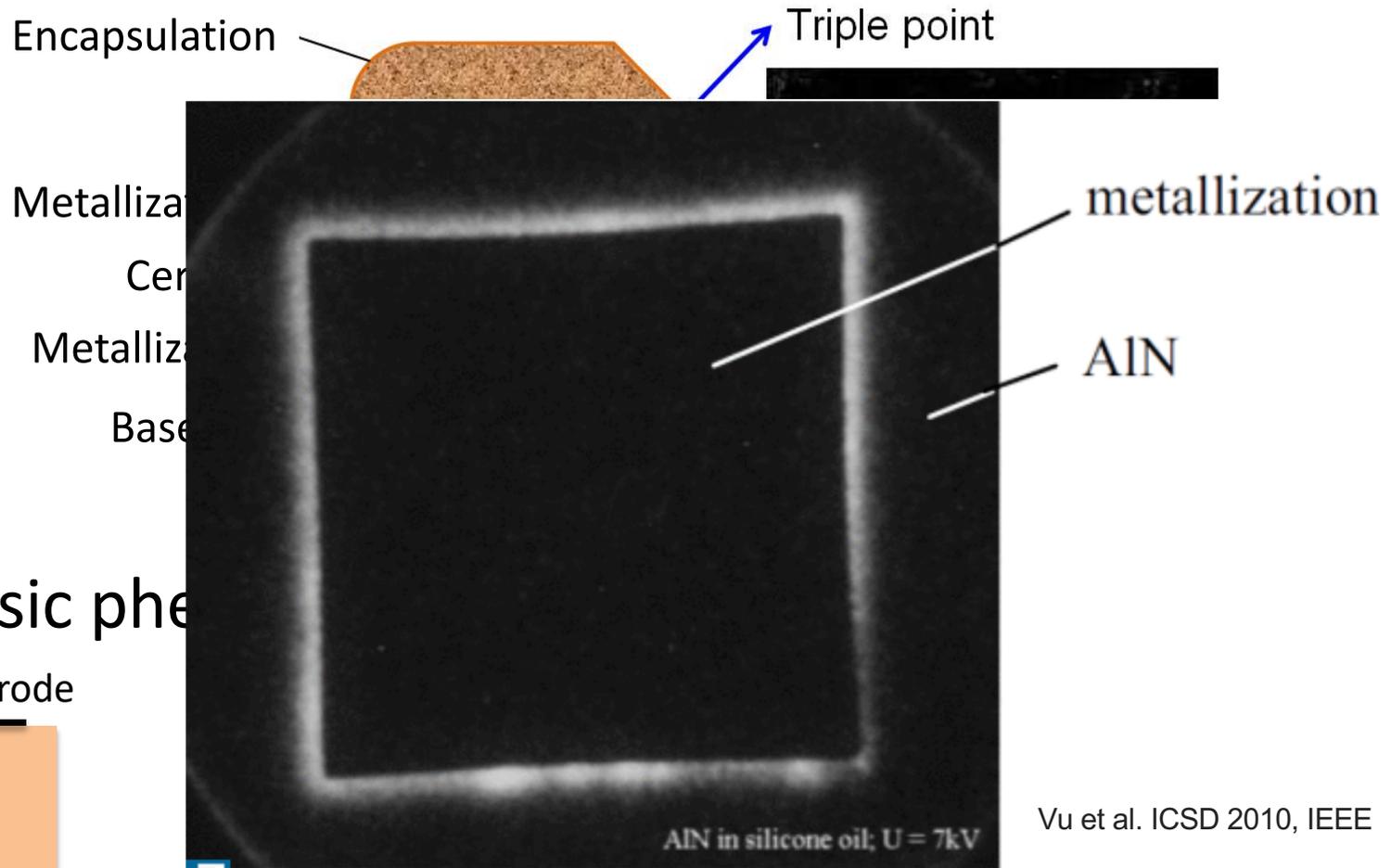
Extrinsic phenomena: Partial discharges



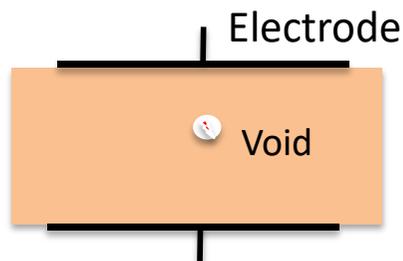
6. Impact of high dV/dt on insulation



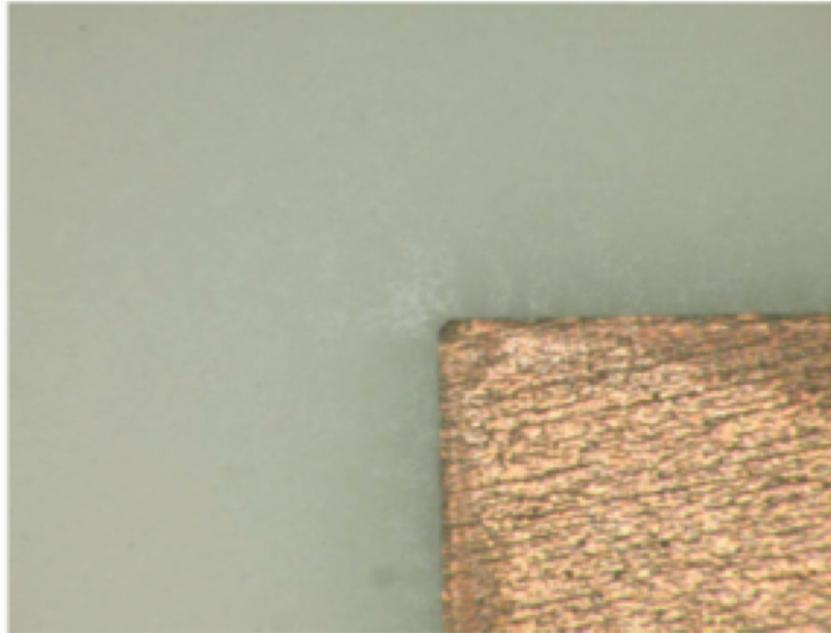
High field at triple point



Extrinsic phe



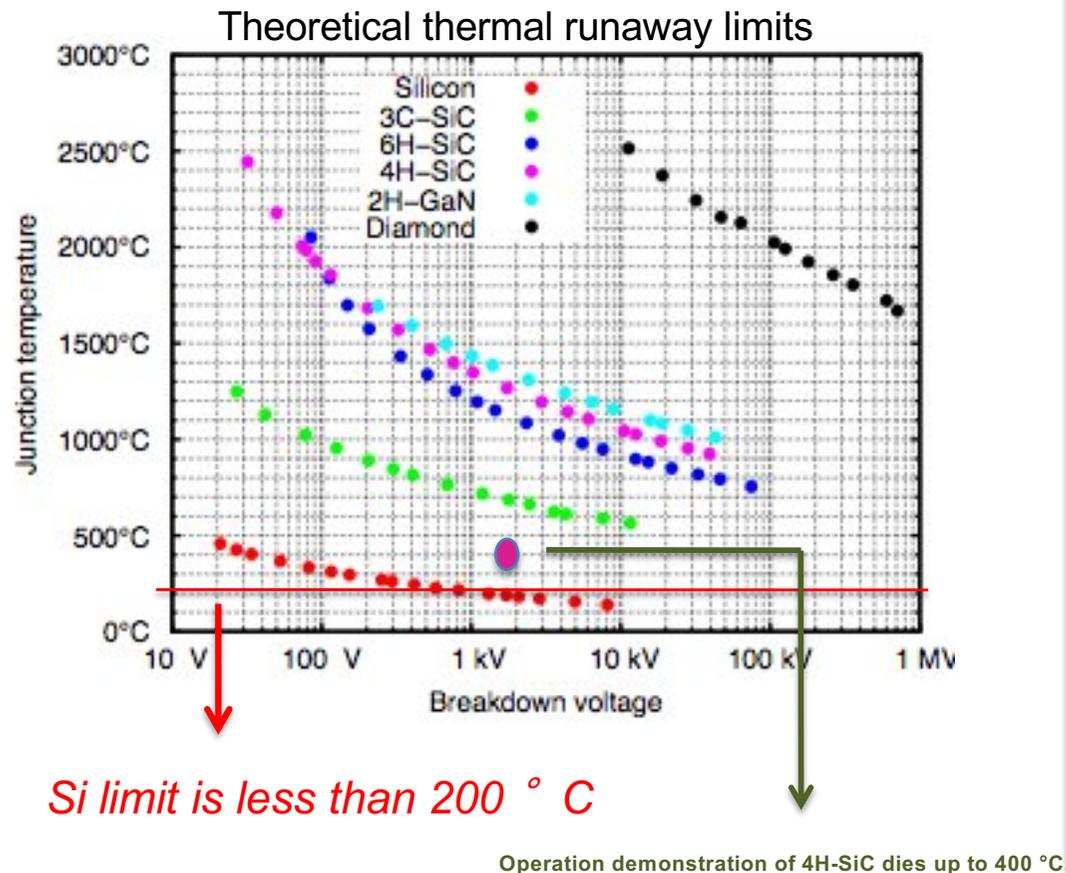
6. Impact of high dV/dt on insulation



Li, Zhe et al. *Dielectrics and Electrical Insulation, IEEE Transactions on*, 18(3), pp 675, 2011

7. Challenges for the future

High temperature ability of wide band gap devices



N.B.: T_{jmax} of commercial packaged devices is still limited today at 175 ° C.

Specific characteristics induced by wide band gap semiconductor devices under operation

- > High electric field
(2 to 10 MV/cm peaks)
- > High temperature (if needed)
(up to 400 ° C)
- > High voltage (if needed)
(up to 10 kV)
- > Ultra fast switching
- > Smaller dies

=> the WBG semiconductor die environnement has to be adapted ...

7. Challenges for the future



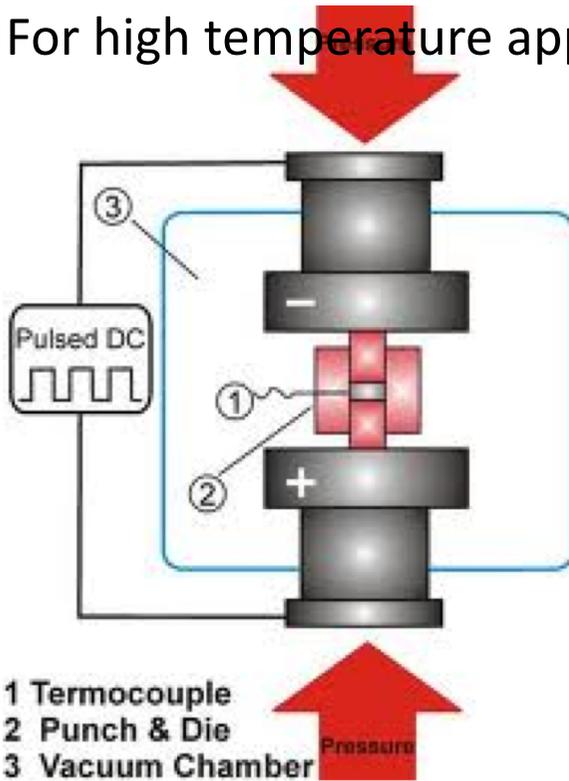
Increase in :

- Power densities and integration
- Operating voltages and dV/dt
- Operating temperatures

Will ceramics continue to be an answer ?

7. Proposals for new substrate technologies

For high temperature applications...



Why TiN ?

hard ceramic , good conductor, compatible CTE

- ◆ $P \leq 200 \text{ MPa max}$
- ◆ $25 < T < 2000^\circ\text{C}$

Thermal conductivity ($\text{W.K}^{-1}.\text{m}^{-1}$)

Electrical resistivity ($\mu\Omega.\text{cm}$)

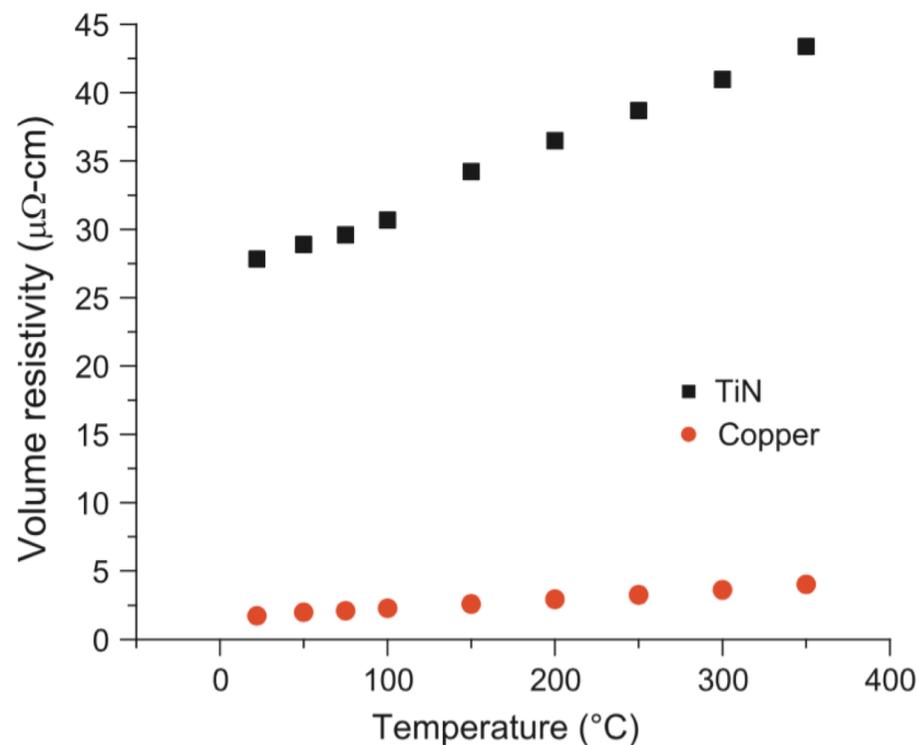
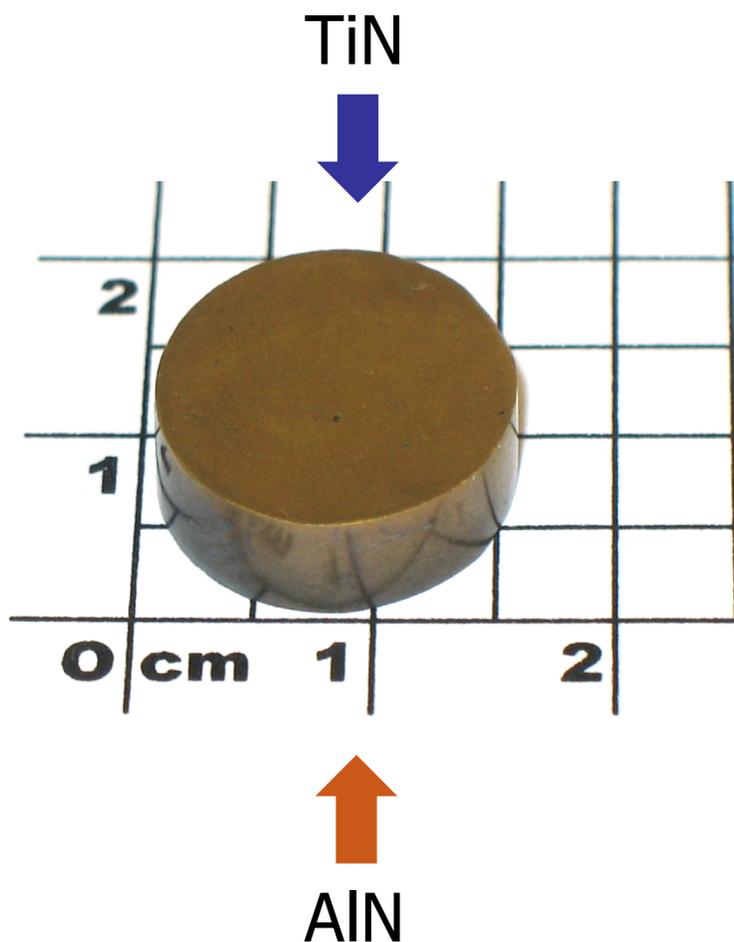
Coef Thermal Expansion (CTE)
20-100 °C (10^{-6} K^{-1})

AlN	Cu	TiN
180	400	40
10^{20}	2	20
4	17	9

7. Proposals for new substrate technologies



For high temperature applications...



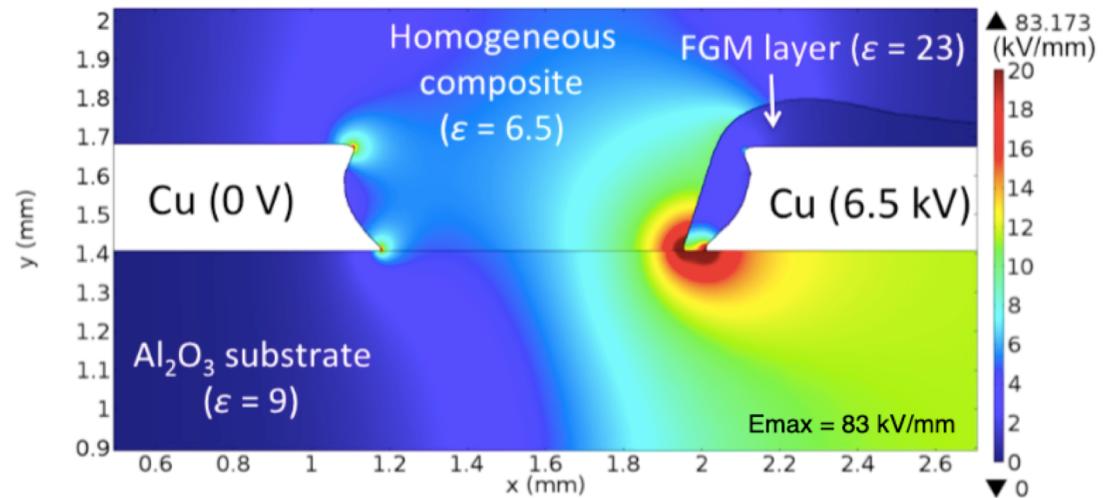
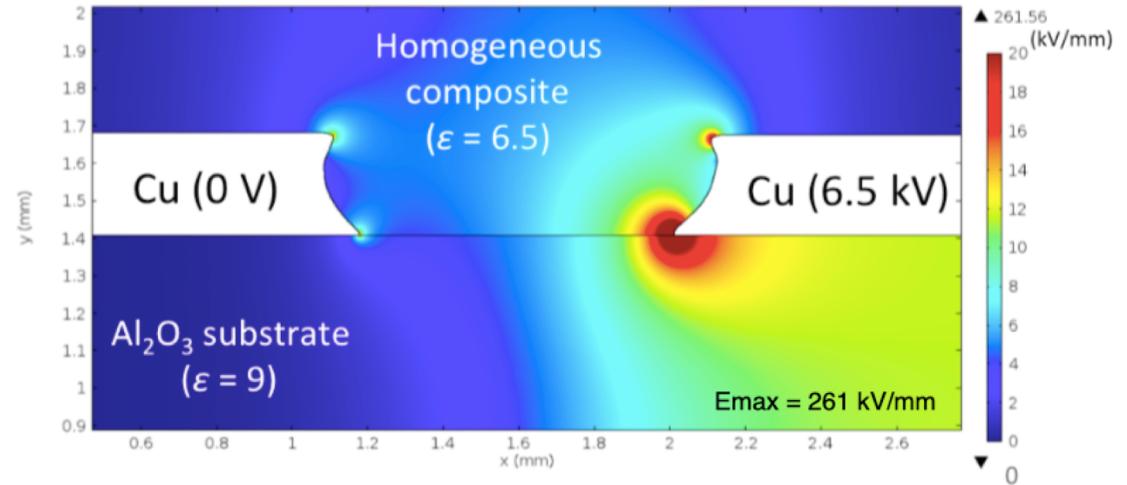
Valdez-Nava et al., Ceramics International, 2013, 8743-8749.

7. Proposals for new substrate technologies



For high voltage applications...

Triple point problem

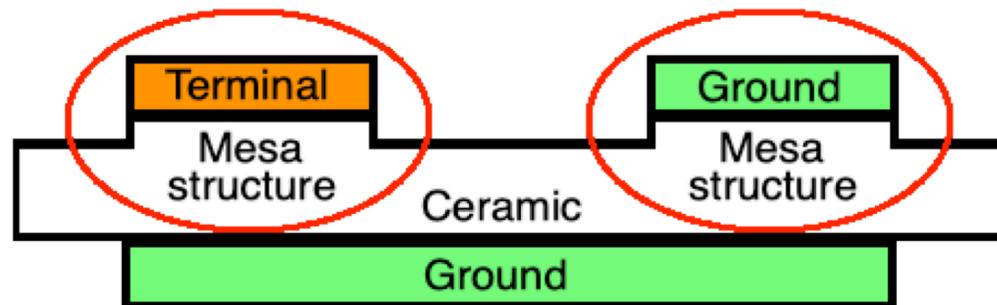
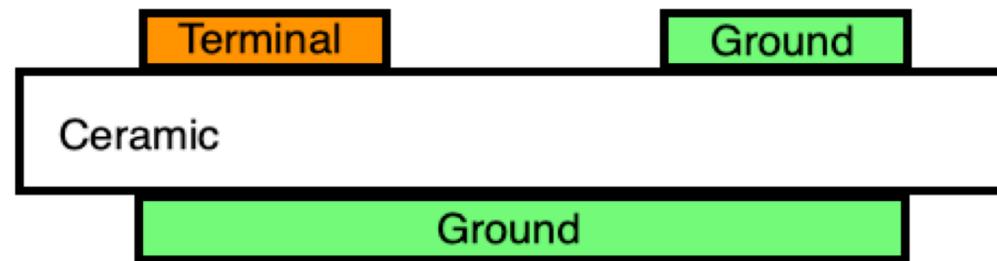


Diaham S., Valdez, Z., et al. 2018 IEEE ICD. IEEE, 2018.

7. Proposals for new substrate technologies

For high voltage applications...

Classic structure

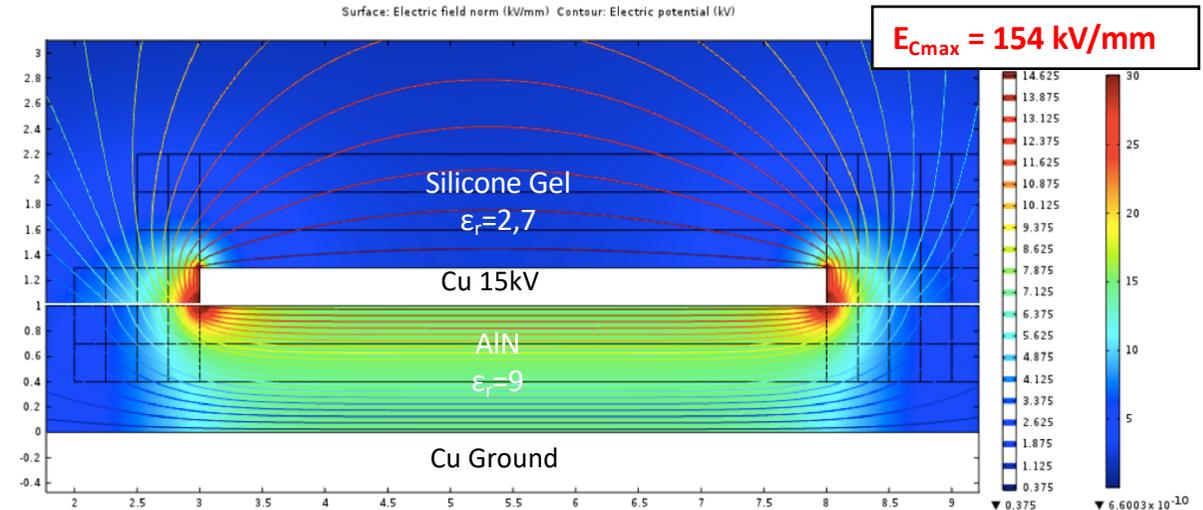
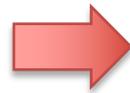
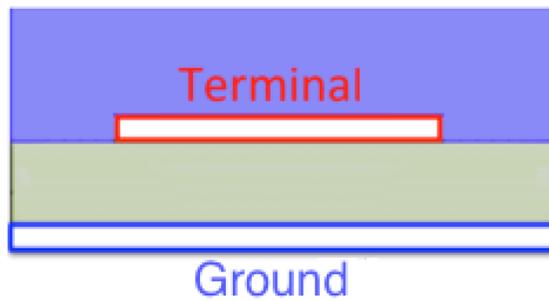


Mesa structure

7. Proposals for new substrate technologies

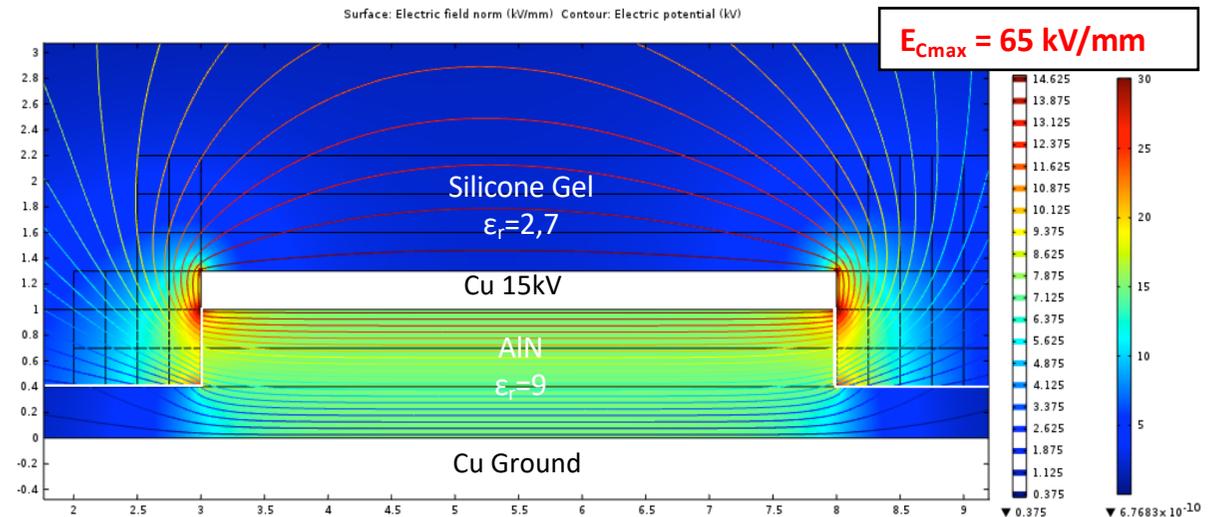
Classic structure

AlN thickness: 1 mm
Voltage: 15 kV



Mesa structure

AlN thickness : 1 mm
Voltage: 15 kV

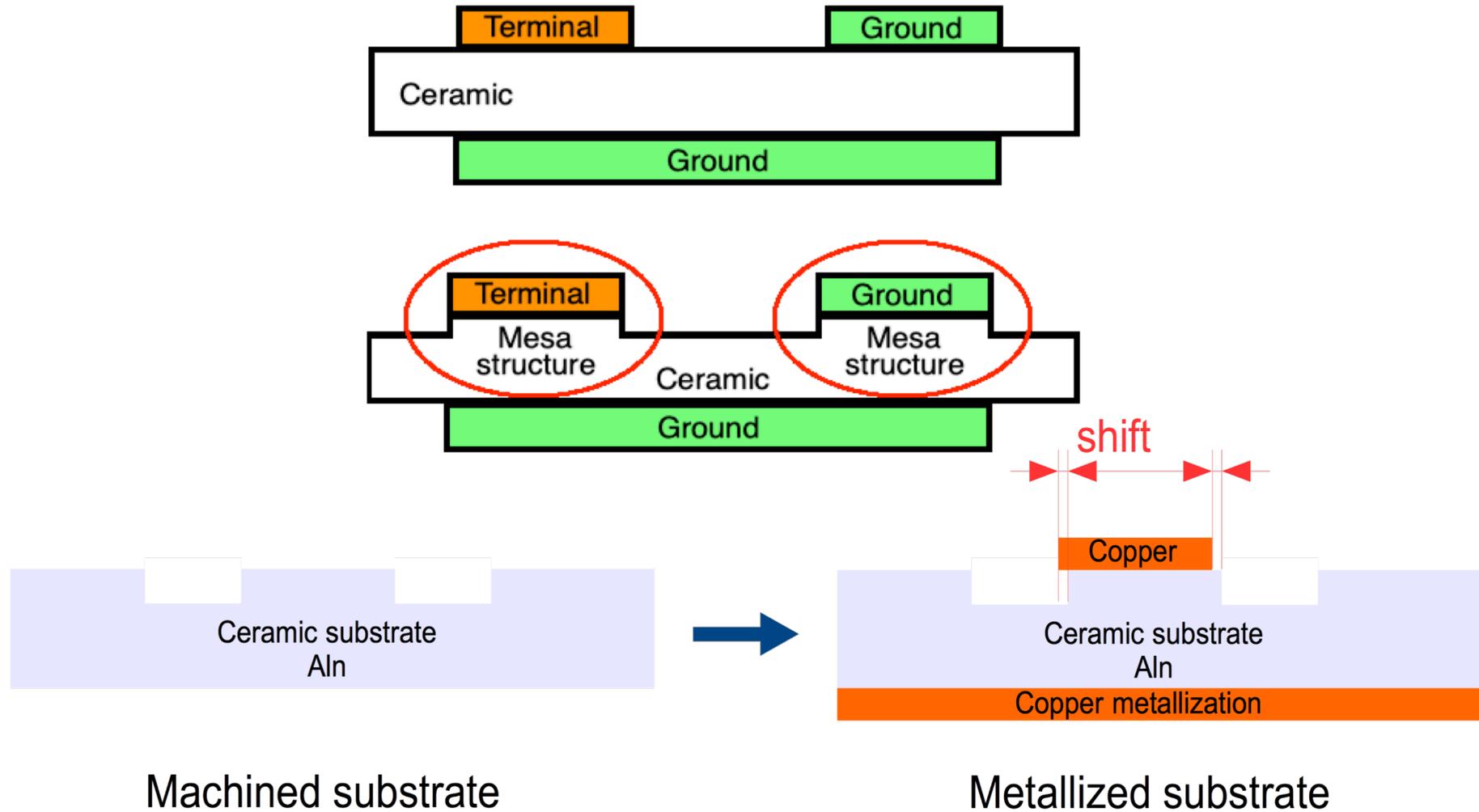


→ Reduction of 57% in the maximum electric field

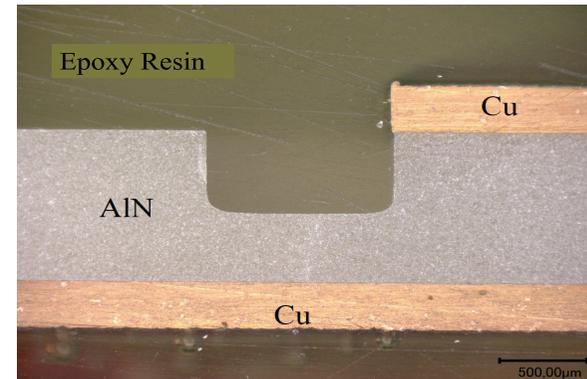
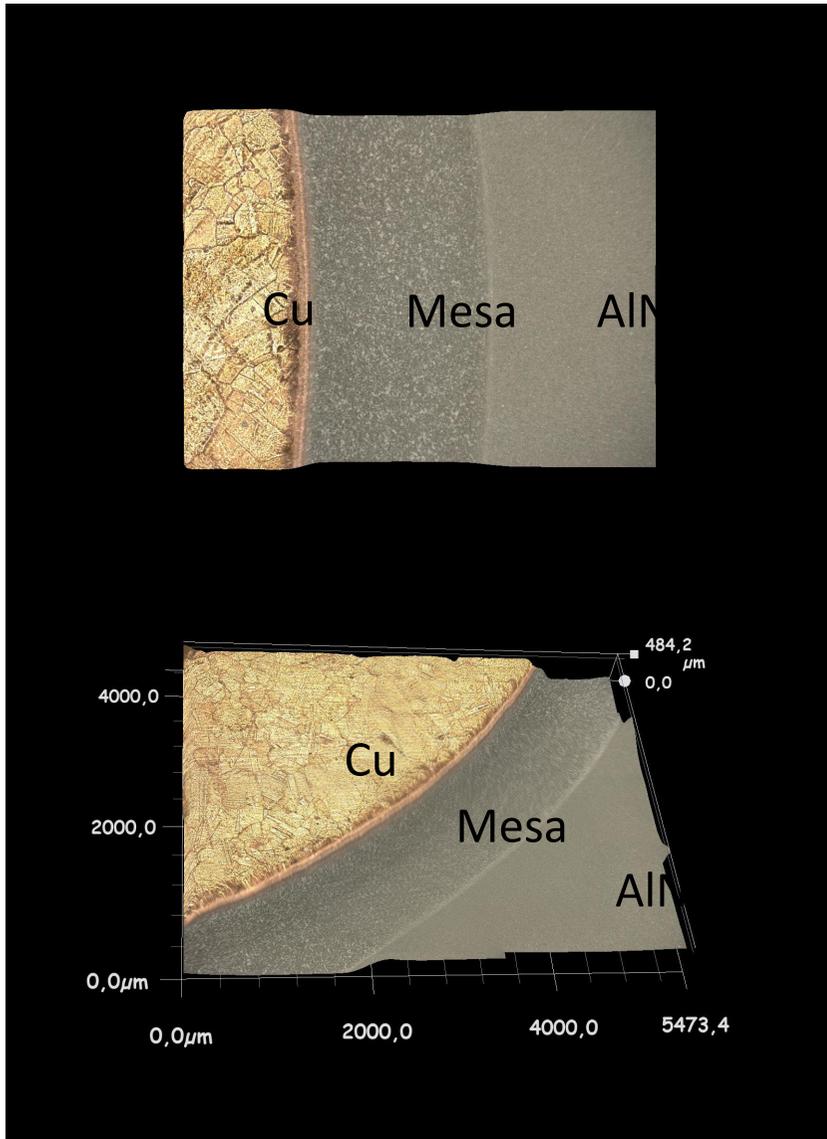
Hourdequin et al. *ICD 2016*, IEEE, 999-1002

7. Proposals for new substrate technologies

For high voltage applications...

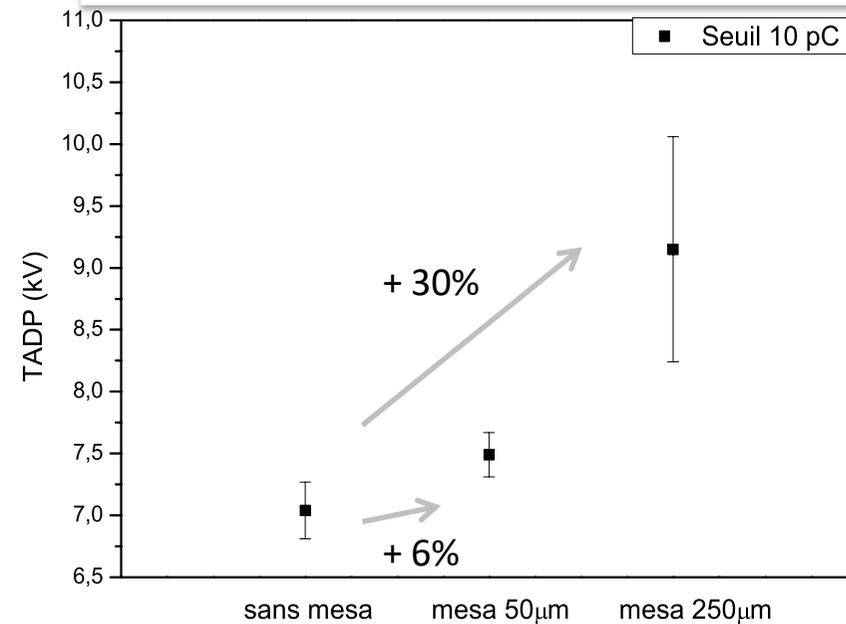


7. Proposals for new substrate technologies



Cross section

PD measurements (PDIV) @ 50Hz

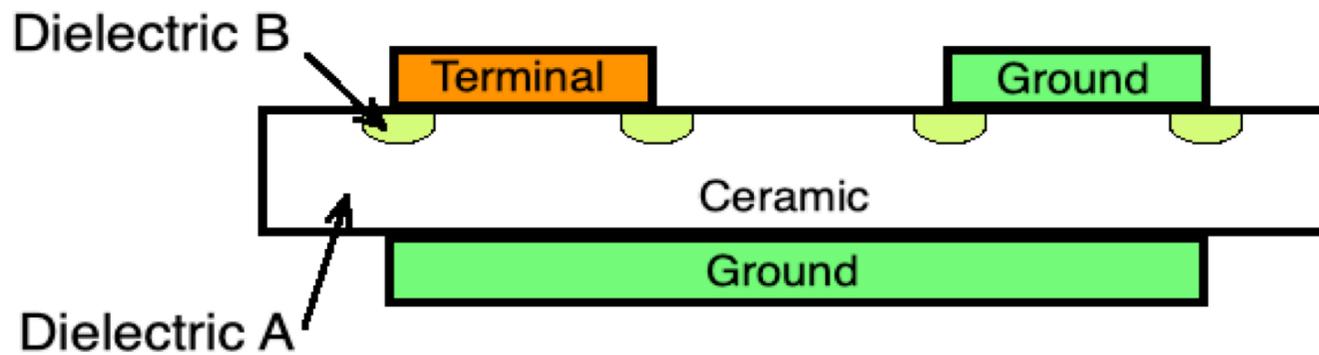


Hourdequin, PhD Thesis, Université de Toulouse, 2018.

7. Proposals for new substrate technologies

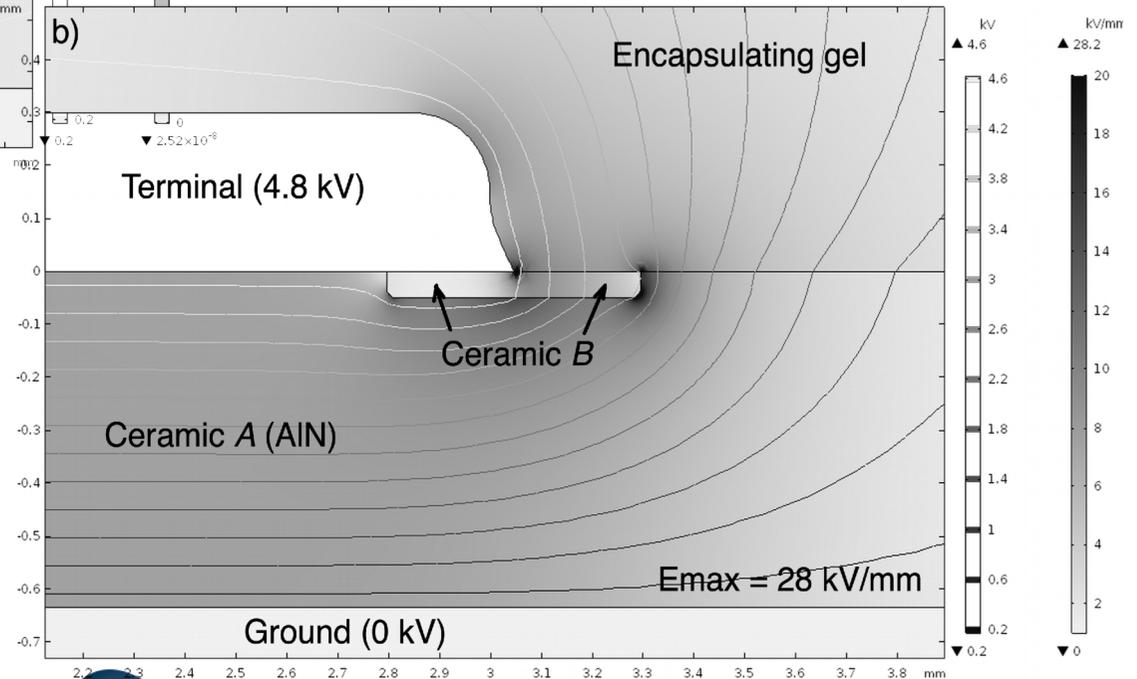
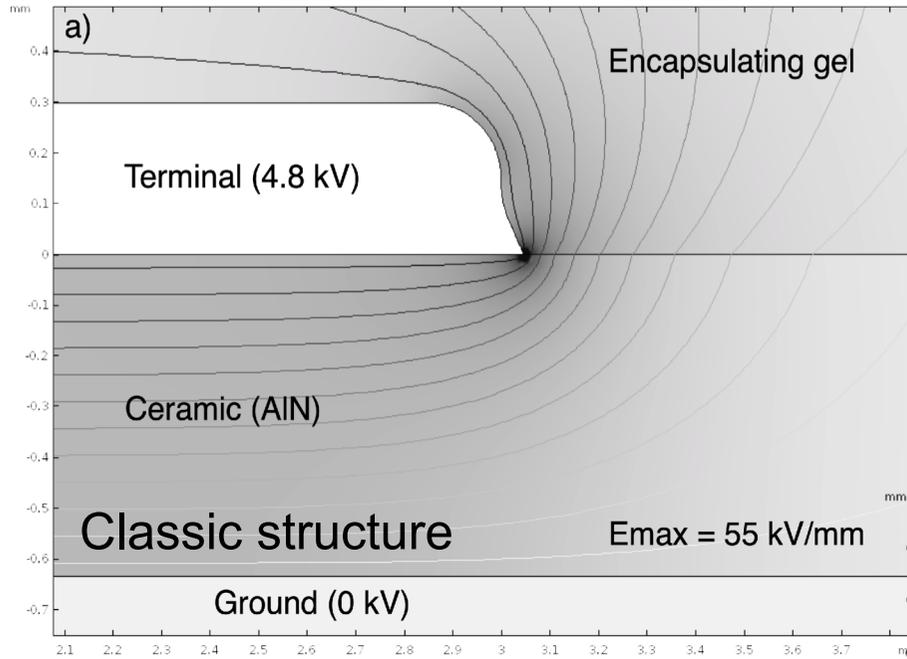
For high voltage applications...

Classic structure



Field grading substrate (FGS)

7. Proposals for new substrate technologies

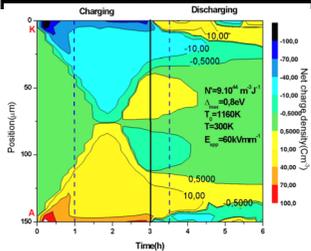
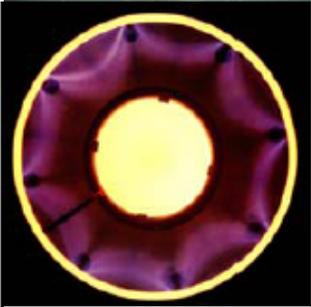
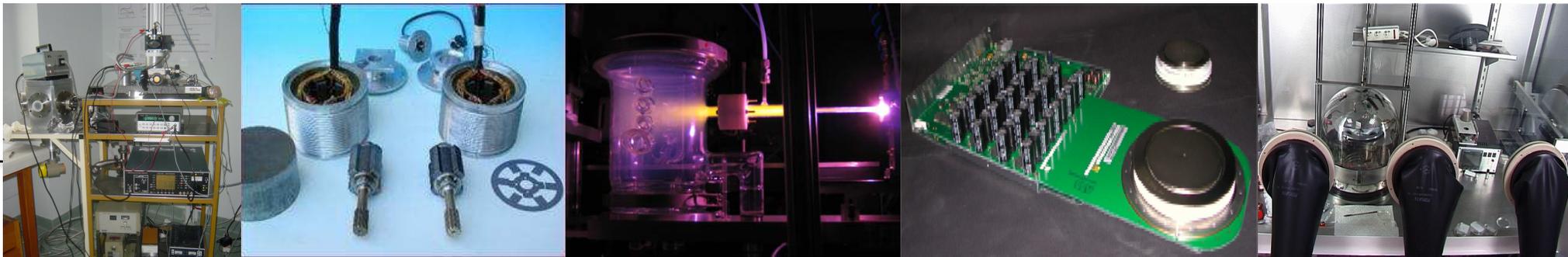


Field grading substrate (FGS)

9. Final remarks



- When high voltage insulation and heat dissipation are required, ceramic substrates remain a first choice in current applications.
- In future applications, a global approach will be required to manage the increase in voltage, electric fields and temperature.



Thanks to our founders:

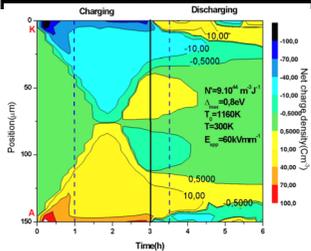
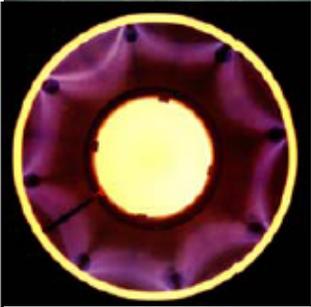
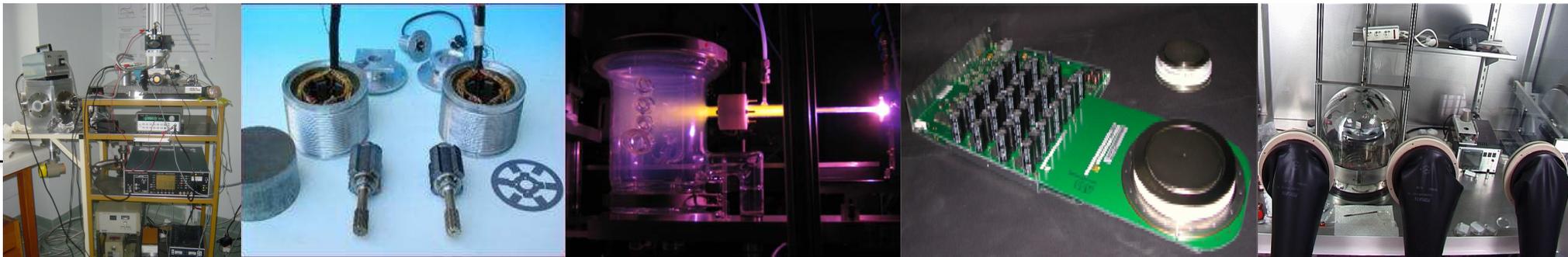


French National Agency for Research



Directorate General of Armaments





Thank you...

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